

Notice of References Cited

Application/Control No.

10/557,824

Applicant(s)/Patent Under
Reexamination
INOUE ET AL.

Examiner

Kwang Han

Art Unit

1795

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,686,083	02-2004	Saito et al.	429/34
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

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